onsemi

Switch - N-Channel

MMBF5103

Features

- This Device is Designed for Low Level Analog Switching, Sample and Hold Circuits and Chopper Stabilized Amplifiers
- Sourced from Process 51
- See J111 for Characteristics
- This is a Pb–Free and Halide Free Device

ABSOLUTE MAXIMUM RATINGS

(Values are at $T_A = 25^{\circ}C$ unless otherwise noted.) (Notes 1 and 2)

Symbol	Parameter	Value	Unit
V _{DG}	Drain-Gate Voltage	40	V
V _{GS}	Gate-Source Voltage	-40	V
I _{GF}	Forward Gate Current	50	mA
T _J , T _{STG}	Operating and Storage Junction Temperature Range	–55 to 150	°C

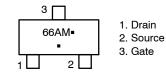
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

- These ratings are based on a maximum junction temperature of 150°C.
 These are steady-state limits. **onsemi** should be consulted on applications involving added a law, dots, and a statement of the state
- involving pulsed or low-duty-cycle operations.



SOT-23 CASE 318-08

MARKING DIAGRAM



66A = Specific Device Code

- M = Date Code
- = Pb-Free Package

ORDERING INFORMATION

	Device	Package	Shipping
MN	IBF5103	SOT–23 (Pb–Free / Halide Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, <u>BRD8011/D</u>.

THERMAL CHARACTERISTICS (Values are at $T_A = 25^{\circ}C$ unless otherwise noted.) (Note 3)

Symbol	Parameter	Value	Unit
PD	Total Device Dissipation	350	mW
	Derate Above 25°C	2.8	mW/°C
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	357	°C/W

3. Device mounted on FR-4 PCB 36 mm × 18 mm × 1.5 mm; mounting pad for the collector lead minimum 6 cm².

ELECTRICAL CHARACTERISTICS Values are at $T_A = 25^{\circ}C$ unless otherwise noted.

Symbol	Parameter	Test Conditions	Min	Max	Unit
OFF CHARAC	TERISTICS				-
V _{(BR)GSS}	Gate-Source Breakdown Voltage	$I_{G} = 1.0 \ \mu A, \ V_{DS} = 0$	-40	-	V
I _{GSS}	Gate Reverse Current	$V_{GS} = -15 \text{ V}, V_{DS} = 0$	-	-200	pА
		V_{GS} = -15 V, V_{DS} = 0, T_A = 125°C	-	-500	nA
V _{GS} (off)	Gate-Source Cut-Off Voltage	V _{DS} = 20 V, I _D = 1.0 nA	-1.2	-2.7	V
V _{GS} (f)	Gate-Source Forward Voltage	I _G = 1.0 mA, V _{DS} = 0	-	1.0	V
ON CHARACT	TERISTICS				
I _{DSS}	Zero-Gate Voltage Drain Current (Note 4)	$V_{DS} = 15 \text{ V}, \text{ V}_{GS} = 0$	10	40	mA
SMALL SIGNA	AL CHARACTERISTICS	·	-	-	-
C _{iss}	Input Capacitance	V_{DS} = 15 V, V_{GS} = 0, f = 1.0 MHz	_	16	pF
C _{rss}	Reverse Transfer Capacitance	V _{GS} = -15 V, f = 1.0 MHz	-	6.0	pF

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse test with PW = 300 μ s, 1% duty cycle.





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